

FCC EMC Test Report

Report No.: JYTSZ-R01-2500050

Applicant: Shenzhen DOOGEE Hengtong Technology CO., LTD

Address of Applicant: B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park,
No. 22, Dafu Industrial Zone, Guanlan Aobei Community,
Guanlan Street, Longhua New District, Shenzhen, Guangdong
China

Equipment Under Test (EUT)

Product Name: Smart Phone

Model No.: V Max S, V Max Plus, V Max Pro, V Max Ultra, V Max GT, V
Max GT Ultra, V Max GT Pro, V Max SE, V Max Power, V
Max Turbo, V Max 2, V Max Play, V Max Pro+

Trade Mark: DOOGEE

FCC ID: 2AX4YVMAXS

Applicable Standards: FCC CFR Title 47 Part 15B

Date of Sample Receipt: 17 Feb., 2025

Date of Test: 18 Feb., to 03 Apr., 2025

Date of report Issued: 07 Apr., 2025

Test Result: PASS

Project by:	<u>Lu Yan Li</u>	Date:	<u>07 Apr., 2025</u>
Reviewed by:	<u>Heta Zhang</u>	Date:	<u>07 Apr., 2025</u>
Approved by:	<u>Juned Wei</u>	Date:	<u>07 Apr., 2025</u>
	Manager		

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in above the application standard version. Test results reported herein relate only to the item(s) tested.

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1 Version

Version No.	Date	Description
00	07 Apr., 2025	Original

2 Contents

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3 General Information

3.1 Client Information

Applicant:	Shenzhen DOOGEE Hengtong Technology CO., LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China
Manufacturer:	Shenzhen DOOGEE Hengtong Technology CO., LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China
Factory:	Shenzhen DOOGEE Hengtong Technology CO., LTD
Address:	B, 2/F, Building A4, Silicon Valley Power Digital Industrial Park, No. 22, Dafu Industrial Zone, Guanlan Aobei Community, Guanlan Street, Longhua New District, Shenzhen, Guangdong China

3.2 General Description of E.U.T.

Product Name:	Smart Phone
Model No.:	V Max S, V Max Plus, V Max Pro, V Max Ultra, V Max GT, V Max GT Ultra, V Max GT Pro, V Max SE, V Max Power, V Max Turbo, V Max 2, V Max Play, V Max Pro+
Power Supply:	Rechargeable Li-ion Battery DC 3.87V, 22000mAh
AC Adapter:	Model: TP303C-US Input: AC100-220V, 50/60Hz, 0.7A Max Output: USB-C: DC 5.0V, 3.0A 15W; 9.0V, 3.0A 27W; 12.0V, 2.5A 30W; 15.0V, 2.0A 30W; 20V, 1.5A 30W PPS : DC 5.0V-11V, 3.0A 33W
Remark:	Model No.: V Max S, V Max Plus, V Max Pro, V Max Ultra, V Max GT, V Max GT Ultra, V Max GT Pro, V Max SE, V Max Power, V Max Turbo, V Max 2, V Max Play, V Max Pro+ were identical inside, the electrical circuit design, layout, components used and internal wiring, with only difference being model name.
Test Sample Condition:	The test samples were provided in good working order with no visible defects.

3.3 Test Mode

Operating Mode	Detail Description
PC mode	Keep the EUT in Downloading mode(Worst case)
Charging+Recording mode	Keep the EUT in Charging+Recording mode
Charging+Playing mode	Keep the EUT in Charging+Playing mode
FM mode	Keep the EUT in FM receiver mode
GPS mode	Keep the EUT in GPS receiver mode

The sample was placed 0.8m above the ground plane of 3m chamber. Measurements in both horizontal and vertical polarities were performed. During the test, each emission was maximized by: having the EUT continuously working, investigated all operating modes, rotated about all 3 axis (X, Y & Z) and considered typical configuration to obtain worst position, manipulating interconnecting cables, rotating the turntable, varying antenna height from 1m to 4m in both horizontal and vertical polarizations. The emissions worst-case are shown in Test Results of the following pages.

3.4 Description of Test Auxiliary Equipment

Manufacturer	Description	Model	S/N	FCC ID/DoC
Lenovo	Laptop	ThinkPad T14 Gen 1	SL10Z47277	DoC
HP	Printer	HP LaserJet P1007	VNFP409729	DoC

3.5 Description of Cable Used

Cable Type	Description	Length	From	To
Detached USB Cable	Shielding	1.0m	EUT	PC/Adapter

3.6 Measurement Uncertainty

Parameter	Expanded Uncertainty (Confidence of 95%(U = 2Uc(y)))
Conducted Emission for LISN (9kHz ~ 150kHz)	±3.0 dB
Conducted Emission for LISN (150kHz ~ 30MHz)	±2.4 dB
Radiated Emission (30MHz ~ 200MHz) (3m SAC)	±4.6 dB
Radiated Emission (200MHz ~ 1000MHz) (3m SAC)	±5.8 dB
Radiated Emission (1GHz ~ 6GHz) (3m SAC)	±4.5 dB

Note: All the measurement uncertainty value were shown with a coverage $k=2$ to indicate 95% level of confidence. The measurement data show herein meets or exceeds the CISPR measurement uncertainty values specified in CISPR 16-4-2 and can be compared directly to specified limit to determine compliance.

3.7 Additions to, Deviations, or Exclusions from the Method

No

3.8 Laboratory Facility

The test facility is recognized, certified, or accredited by the following organizations:

● **FCC - Designation No.: CN1211**

JianYan Testing Group Shenzhen Co., Ltd. has been accredited as a testing laboratory by FCC(Federal Communications Commission). The test firm Registration No. is 727551.

● **ISED – CAB identifier.: CN0021**

The 3m Semi-anechoic chamber and 10m Semi-anechoic chamber of JianYan Testing Group Shenzhen Co., Ltd. has been Registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 10106A-1.

● **CNAS - Registration No.: CNAS L15527**

JianYan Testing Group Shenzhen Co., Ltd. is accredited to ISO/IEC 17025:2017 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L15527.

● **A2LA - Registration No.: 4346.01**

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. The test scope can be found as below link: <https://portal.a2la.org/scopepdf/4346-01.pdf>

3.9 Laboratory Location

JianYan Testing Group Shenzhen Co., Ltd.

Address: No.101, Building 8, Innovation Wisdom Port, No.155 Hongtian Road, Huangpu Community, Xinqiao Street, Bao'an District, Shenzhen, Guangdong, People's Republic of China.

Tel: +86-755-23118282, Fax: +86-755-23116366

Email: info-JYTee@lets.com, Website: <http://jyt.lets.com>

3.10 Test Instruments List

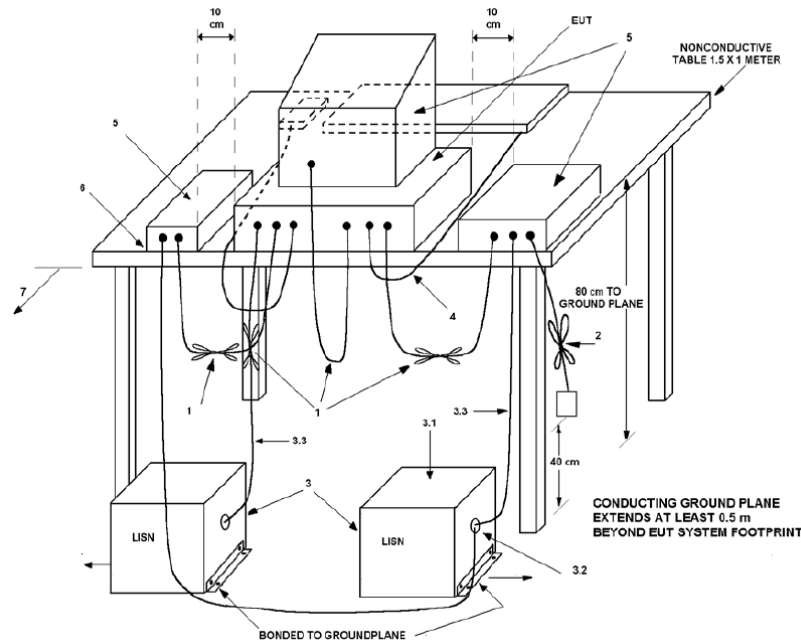
Radiated Emission(3m SAC):					
Test Equipment	Manufacturer	Model No.	Manage No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
3m SAC	ETS	9m*6m*6m	WXJ001-1	04-14-2021	04-13-2026
BiConiLog Antenna	Schwarzbeck	VULB9163	WXJ002	01-03-2025	01-02-2026
Horn Antenna	Schwarzbeck	BBHA9120D	WXJ002-2	01-03-2025	01-02-2026
Pre-amplifier (30MHz ~ 1GHz)	Schwarzbeck	BBV9743B	WXJ001-2	12-16-2024	12-15-2025
Pre-amplifier (1GHz ~ 18GHz)	SKET	LNPA_0118G-50	WXJ001-3	12-16-2024	12-15-2025
EMI Test Receiver	Rohde & Schwarz	ESRP7	WXJ003-1	12-16-2024	12-15-2025
Spectrum Analyzer	Rohde & Schwarz	FSP 30	WXJ004	12-16-2024	12-15-2025
Coaxial Cable (30MHz ~ 1GHz)	JYTSZ	JYT3M-1G-NN-8M	WXG001-4	01-15-2025	01-14-2026
Coaxial Cable (1GHz ~ 18GHz)	JYTSZ	JYT3M-18G-NN-8M	WXG001-5	01-15-2025	01-14-2026
Band Reject Filter Group	Tonscend	JS0806-F	WXJ089	N/A	
Test Software	Tonscend	TS+	Version: 3.0.0.1		

Conducted Emission:					
Test Equipment	Manufacturer	Model No.	Manage No.	Cal. Date (mm-dd-yy)	Cal. Due date (mm-dd-yy)
EMI Test Receiver	Rohde & Schwarz	ESR3	WXJ003-2	06-11-2024	06-10-2025
LISN	Schwarzbeck	NSLK 8127	QCJ001-13	12-17-2024	12-16-2025
LISN	Rohde & Schwarz	ESH3-Z5	WXJ005-1	12-17-2024	12-16-2025
LISN Coaxial Cable (9kHz ~ 30MHz)	JYTSZ	JYTCE-1G-NN-2M	WXG003-1	01-15-2025	01-14-2026
RF Switch	TOP PRECISION	RSU0301	WXG003	N/A	
Test Software	AUDIX	E3	Version: 6.110919b		

4 Measurement Setup and Procedure

4.1 Test Setup

1) Conducted emission measurement:



Note: The detailed descriptions please refer to Figure 8 of ANSI C63.4:2014.

2) Radiated emission measurement:

Below 1GHz (3m SAC)





4.2 Test Procedure

Test method	Test step
Conducted emission	1. The E.U.T and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm/50uH coupling impedance for the measuring equipment. 2. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refer to the block diagram of the test setup and photographs). 3. Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.4 on conducted measurement.
Radiated emission	For below 1GHz: 1. The EUT was placed on the tabletop of a rotating table 0.8 m the ground at a 3 m semi anechoic chamber. The measurement distance from the EUT to the receiving antenna is 3 m. 2. EUT works in each mode of operation that needs to be tested, and having the EUT continuously working, respectively on 3 axis (X, Y & Z) and considered typical configuration to obtain worst position. The highest signal levels relative to the limit shall be determined by rotating the EUT from 0° to 360° and with varying the measurement antenna height between 1 m and 4 m in vertical and horizontal polarizations. 3. Open the test software to control the test antenna and test turntable. Perform the test, save the test results, and export the test data. For above 1GHz: 1. The EUT was placed on the tabletop of a rotating table 0.8 m the ground at a 3 m fully anechoic room. The measurement distance from the EUT to the receiving antenna is 3 m. 2. EUT works in each mode of operation that needs to be tested, and having the EUT continuously working, respectively on 3 axis (X, Y & Z) and considered typical configuration to obtain worst position. The highest signal levels relative to the limit shall be determined by rotating the EUT from 0° to 360° and with varying the measurement antenna height between 1 m and 4 m in vertical and horizontal polarizations. 3. Open the test software to control the test antenna and test turntable. Perform the test, save the test results, and export the test data.

5 Test Results

5.1 Summary

5.1.1 Clause and data summary

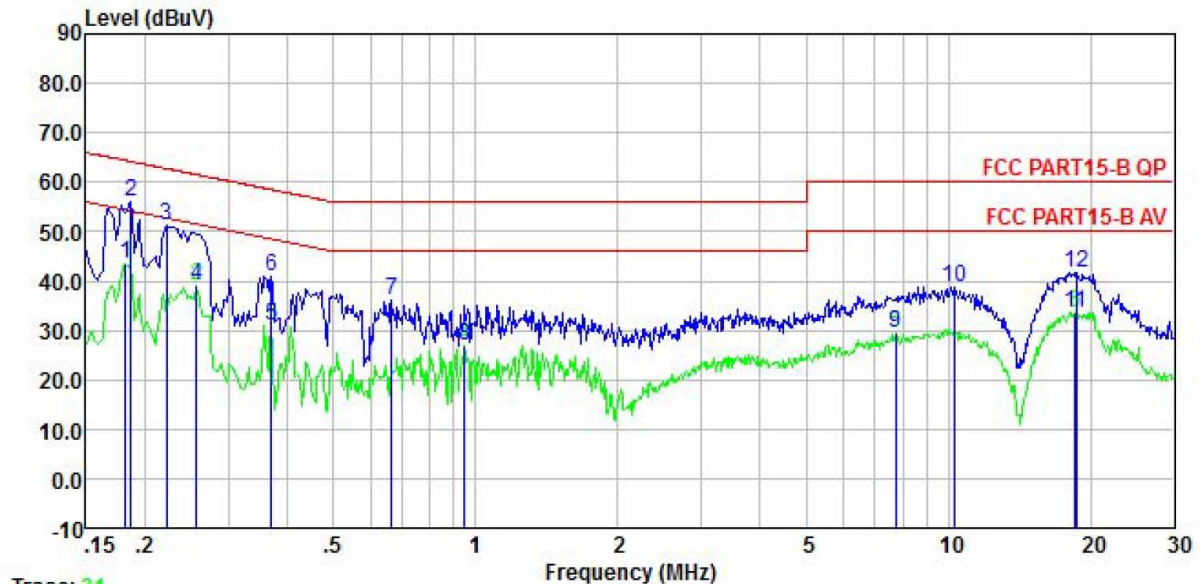
Test items	Standard clause	Test data	Result
Conducted Emission	Part 15.107	See Section 5.2	Pass
Radiated Emission	Part 15.109	See Section 5.3	Pass
Remark: 1. The EUT is a Class B digital device. 2. Pass: The EUT complies with the essential requirements in the standard. 3. N/A: Not Applicable.			
Test Method:	ANSI C63.4:2014		

5.1.2 Test Limit

Test items	Limit																																																					
Conducted Emission	<table><tr><th rowspan="2">Frequency (MHz)</th><th colspan="2">Class A Limit (dBμV)</th><th colspan="2">Class B Limit (dBμV)</th></tr><tr><th>Quasi-Peak</th><th>Average</th><th>Quasi-Peak</th><th>Average</th></tr><tr><td>0.15 – 0.5</td><td>79</td><td>66</td><td>66 to 56 Note 1</td><td>56 to 46 Note 1</td></tr><tr><td>0.5 – 5</td><td>73</td><td>60</td><td>56</td><td>46</td></tr><tr><td>5 – 30</td><td>73</td><td>60</td><td>60</td><td>50</td></tr><tr><td colspan="5">Note 1: The limit level in dBμV decreases linearly with the logarithm of frequency.</td></tr><tr><td colspan="5">Note 2: The more stringent limit applies at transition frequencies.</td></tr></table>	Frequency (MHz)	Class A Limit (dBμV)		Class B Limit (dBμV)		Quasi-Peak	Average	Quasi-Peak	Average	0.15 – 0.5	79	66	66 to 56 Note 1	56 to 46 Note 1	0.5 – 5	73	60	56	46	5 – 30	73	60	60	50	Note 1: The limit level in dBμV decreases linearly with the logarithm of frequency.					Note 2: The more stringent limit applies at transition frequencies.																							
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5.2 Conducted Emission

Product name:	Smart Phone	Product model:	V Max S
Test by:	Alan Chen	Test mode:	PC mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Line
Test voltage:	AC 120 V/60 Hz		

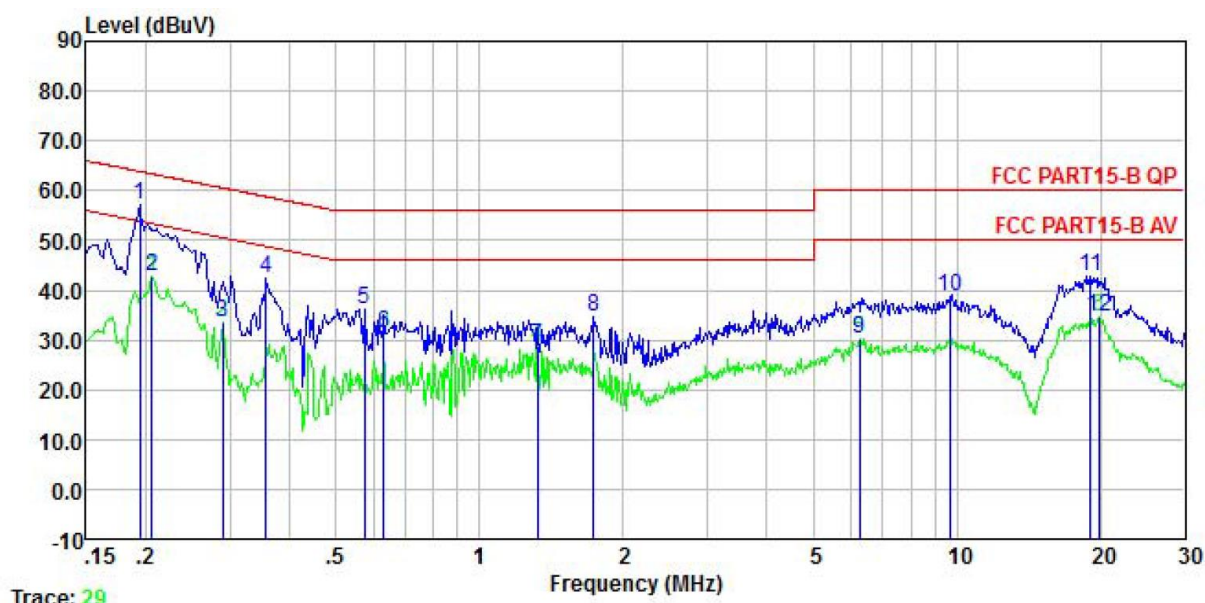


	Freq	Read Level	LISN Factor	Aux Factor	Aux2 Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dB	dB	dBuV	dBuV	dB	
1	0.182	33.75	-0.23	0.00	9.88	0.01	43.41	54.42	-11.01	Average
2	0.186	46.35	-0.22	0.00	9.88	0.02	56.03	64.20	-8.17	QP
3	0.222	41.52	-0.20	0.00	9.88	0.03	51.23	62.74	-11.51	QP
4	0.258	29.36	-0.20	0.00	9.88	0.01	39.05	51.51	-12.46	Average
5	0.369	21.35	-0.20	0.00	9.88	0.03	31.06	48.52	-17.46	Average
6	0.369	31.11	-0.20	0.00	9.88	0.03	40.82	58.52	-17.70	QP
7	0.665	26.51	-0.20	0.00	9.88	0.03	36.22	56.00	-19.78	QP
8	0.948	17.34	-0.28	0.00	9.88	0.05	26.99	46.00	-19.01	Average
9	7.728	19.82	-0.27	0.00	9.90	0.10	29.55	50.00	-20.45	Average
10	10.342	28.96	-0.21	0.00	9.91	0.12	38.78	60.00	-21.22	QP
11	18.524	23.94	-0.37	0.00	9.95	0.15	33.67	50.00	-16.33	Average
12	18.721	31.90	-0.38	0.00	9.95	0.15	41.62	60.00	-18.38	QP

Remark:

1. Level = Read level + LISN Factor + Cable Loss.

Product name:	Smart Phone	Product model:	V Max S
Test by:	Alan Chen	Test mode:	PC mode
Test frequency:	150 kHz ~ 30 MHz	Phase:	Neutral
Test voltage:	AC 120 V/60 Hz		



	Freq	Read Level	LISN Factor	Aux Factor	Aux2 Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dB	dB	dBuV	dBuV	dB	
1	0.194	47.37	-0.20	0.00	9.88	0.03	57.08	63.84	-6.76	QP
2	0.206	33.17	-0.20	0.00	9.88	0.04	42.89	53.36	-10.47	Average
3	0.289	23.96	-0.24	0.00	9.88	0.03	33.63	50.54	-16.91	Average
4	0.358	32.75	-0.26	0.00	9.88	0.02	42.39	58.78	-16.39	QP
5	0.573	26.47	-0.30	0.00	9.88	0.02	36.07	56.00	-19.93	QP
6	0.630	21.80	-0.30	0.00	9.88	0.02	31.40	46.00	-14.60	Average
7	1.324	19.09	-0.30	0.00	9.88	0.11	28.78	46.00	-17.22	Average
8	1.734	24.93	-0.30	0.00	9.88	0.18	34.69	56.00	-21.31	QP
9	6.252	20.73	-0.40	0.00	9.90	0.09	30.32	50.00	-19.68	Average
10	9.654	28.91	-0.40	0.00	9.91	0.12	38.54	60.00	-21.46	QP
11	19.021	33.11	-0.40	0.00	9.95	0.15	42.81	60.00	-17.19	QP
12	19.845	24.76	-0.40	0.00	9.96	0.15	34.47	50.00	-15.53	Average

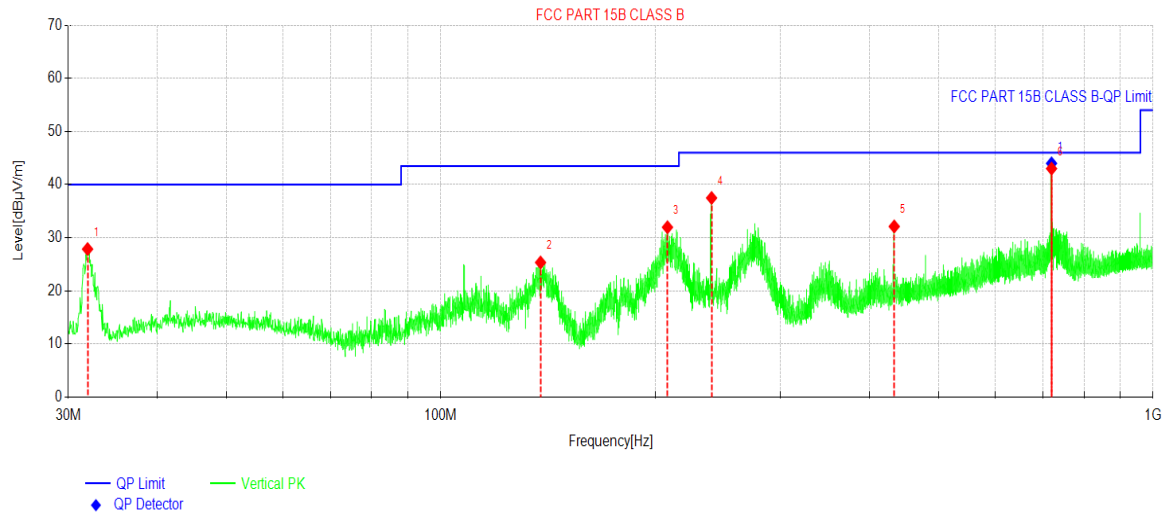
Remark:

1. Level = Read level + LISN Factor + Cable Loss.

5.3 Radiated Emission

Below 1GHz:

Product Name:	Smart Phone	Product Model:	V Max S
Test By:	Kiran Zeng	Test mode:	PC mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Vertical
Test Voltage:	AC 120V/60Hz		



Suspected Data List

NO.	Freq. [MHz]	Reading [dBμV/m]	Factor [dB]	Level [dBμV/m]	Limit [dBμV/m]	Margin [dB]	Trace	Polarity
1	31.9401	43.49	-15.63	27.86	40.00	12.14	PK	Vertical
2	138.1119	43.25	-17.91	25.34	43.50	18.16	PK	Vertical
3	208.1494	46.96	-14.99	31.97	43.50	11.53	PK	Vertical
4	240.0640	51.40	-13.92	37.48	46.00	8.52	PK	Vertical
5	433.2492	41.94	-9.83	32.11	46.00	13.89	PK	Vertical
6	720.4320	47.74	-4.73	43.01	46.00	2.99	PK	Vertical

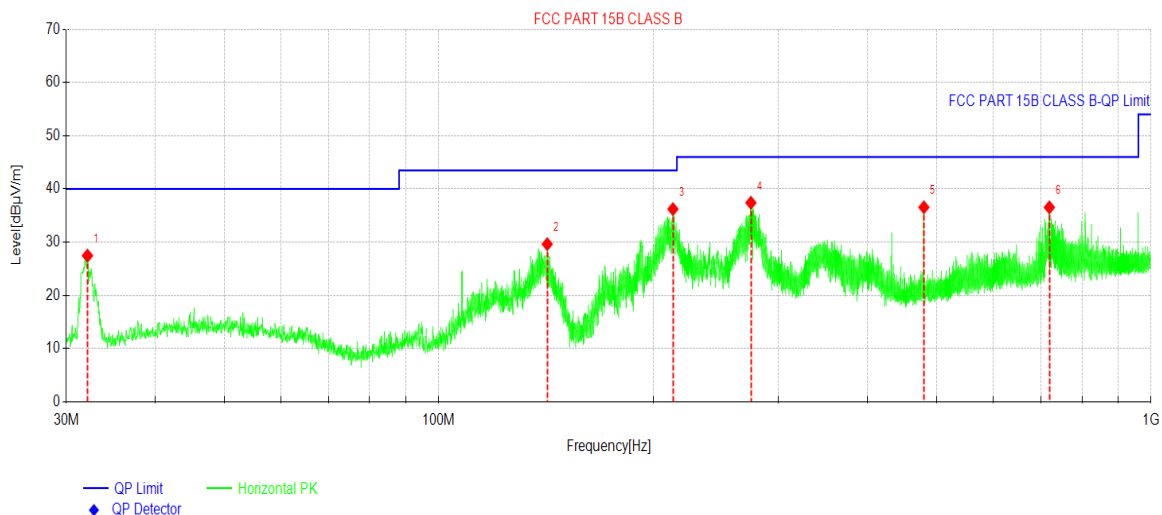
Final Data List

NO.	Freq. [MHz]	QP Reading [dBμV/m]	Factor [dB]	QP Value [dBμV/m]	QP Limit [dBμV/m]	QP Margin [dB]	Angle [°]	Verdict
1	720.4320	48.72	-4.73	43.99	46.00	2.01	39	PASS

Remark:

1. Level = Reading + Factor(Antenna Factor + Cable Loss – Preamplifier Factor).

Product Name:	Smart Phone	Product Model:	V Max S
Test By:	Kiran Zeng	Test mode:	PC mode
Test Frequency:	30 MHz ~ 1 GHz	Polarization:	Horizontal
Test Voltage:	AC 120V/60Hz		



Suspected Data List

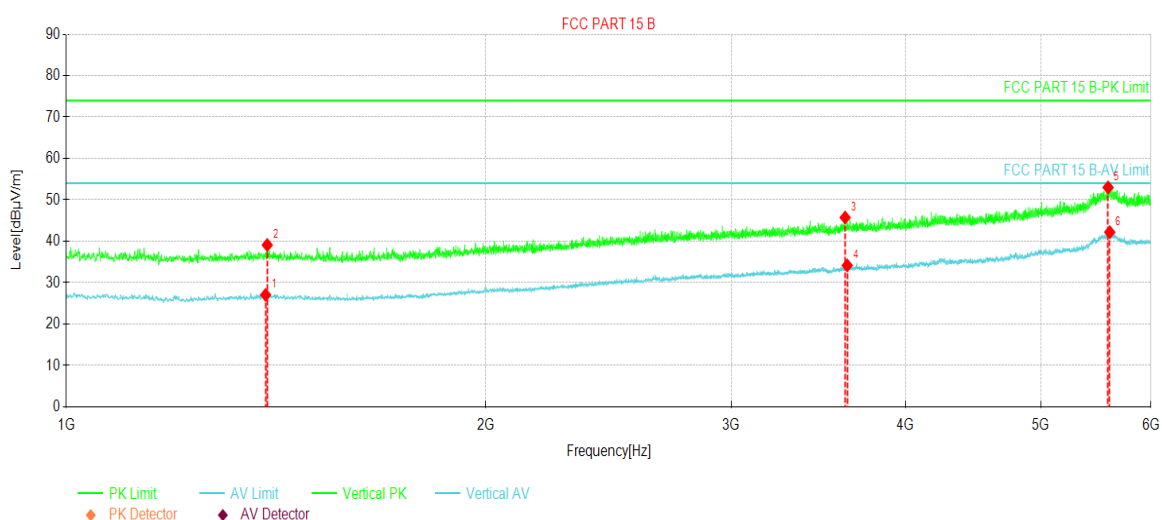
NO.	Freq. [MHz]	Reading [dBμV/m]	Factor [dB]	Level [dBμV/m]	Limit [dBμV/m]	Margin [dB]	Trace	Polarity
1	32.1341	43.10	-15.63	27.47	40.00	12.53	PK	Horizontal
2	142.0406	47.62	-17.99	29.63	43.50	13.87	PK	Horizontal
3	213.2422	51.30	-15.09	36.21	43.50	7.29	PK	Horizontal
4	274.3552	50.75	-13.34	37.41	46.00	8.59	PK	Horizontal
5	479.9570	45.63	-9.07	36.56	46.00	9.44	PK	Horizontal
6	720.0440	41.26	-4.72	36.54	46.00	9.46	PK	Horizontal

Remark:

1. Level = Reading + Factor(Antenna Factor + Cable Loss – Preamplifier Factor).

Above 1GHz:

Product Name:	Smart Phone	Product Model:	V Max S
Test By:	Kiran Zeng	Test mode:	BLE Tx (LE 1M PHY)
Test Frequency:	1000 MHz ~ 6000 MHz	Polarization:	Vertical
Test Voltage:	AC 120V/60Hz		



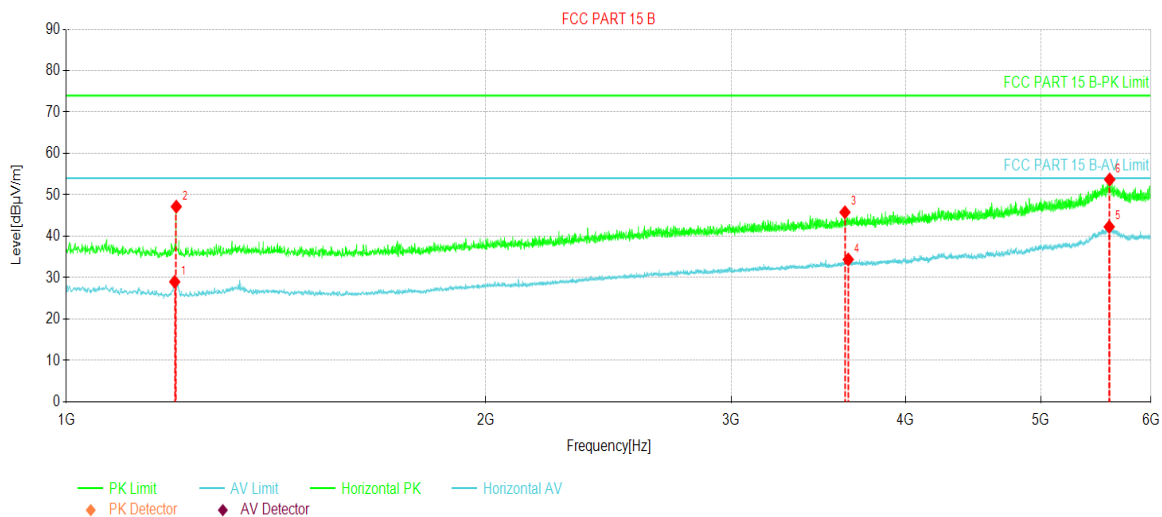
Suspected Data List

NO.	Freq. [MHz]	Reading [dBμV/m]	Level [dBμV/m]	Factor [dB]	Limit [dBμV/m]	Margin [dB]	Trace	Polarity
1	1390.0488	49.12	27.04	-22.08	54.00	26.96	AV	Vertical
2	1393.7992	61.15	39.09	-22.06	74.00	34.91	PK	Vertical
3	3620.3275	60.52	45.74	-14.78	74.00	28.26	PK	Vertical
4	3632.8291	48.93	34.17	-14.76	54.00	19.83	AV	Vertical
5	5589.9487	57.74	53.00	-4.74	74.00	21.00	PK	Vertical
6	5604.9506	46.82	42.20	-4.62	54.00	11.80	AV	Vertical

Remark:

1. Level = Reading + Factor(Antenna Factor + Cable Loss – Preamplifier Factor).

Product Name:	Smart Phone	Product Model:	V Max S
Test By:	Kiran Zeng	Test mode:	BLE Tx (LE 1M PHY)
Test Frequency:	1000 MHz ~ 6000 MHz	Polarization:	Horizontal
Test Voltage:	AC 120V/60Hz		



Suspected Data List

NO.	Freq. [MHz]	Reading [dBμV/m]	Level [dBμV/m]	Factor [dB]	Limit [dBμV/m]	Margin [dB]	Trace	Polarity
1	1196.2745	51.77	29.00	-22.77	54.00	25.00	AV	Horizontal
2	1199.3999	69.94	47.16	-22.78	74.00	26.84	PK	Horizontal
3	3619.0774	60.57	45.79	-14.78	74.00	28.21	PK	Horizontal
4	3639.0799	49.13	34.39	-14.74	54.00	19.61	AV	Horizontal
5	5599.9500	46.85	42.28	-4.57	54.00	11.72	AV	Horizontal
6	5604.3255	58.32	53.71	-4.61	74.00	20.29	PK	Horizontal

Remark:

1. Level = Reading + Factor(Antenna Factor + Cable Loss – Preamplifier Factor).

-----End of report-----